Amendments to the Claims:

This listing of claims will replace all prior versions, and listings, of claims in the application. Please cancel claims 2, 3, and 8-15. Please amend claims 1 and 5-7, as follows:

Listing of Claims:

1. (Currently amended) A method of transferring read data from a memory device, the memory device including a data bus <u>having X data signals</u> and including at least one data masking pin adapted to receive a data masking signal during write operations of the memory, the method comprising:

placing a current read data word on the data bus, the read data word including 2N a plurality of data signals and each data signal having a logic state, X an integer multiple of 2N;

developing a next read data word, the next read data word including 2N a plurality of data signals and each data signal having a logic state;

comparing the logic state of each data signal in the current read data word to the logic state of the corresponding data signal in the next read data word;

determining the number of data signals in the next read data word that are changing from a first logic state in the current read data word to the complementary logic state in the next read data word:

when the determined number of data signals changing from the first logic state to the complementary logic state is greater than N,

developing an inverted next read data word, each data signal in the inverted next read data word having a logic state that is the complementary logic state of the corresponding data signal in the next read data word, and

activating a data bus inversion signal;

simultaneously applying a plurality of placing the inverted next read data words on the data bus; and

for each inverted next read data word, applying a respective the activated data bus inversion signal on an associated one of the data masking pins.

- 2. (Cancelled)
- 3. (Cancelled)
- 4. (Original) The method of claim 1 further comprising deactivating the data bus inversion signal when the determined number of data signals changing from the first logic state to the complementary logic state is less than or equal to N.
- 5. (Currently amended) A method of transferring read data from a memory device, the memory device including a data bus <u>having X data bits</u> and including a <u>plurality of</u> data masking pin adapted to receive a masking signal during write operations of the memory device, the method comprising:

placing a sequence of read data words on the data bus, each read data word having 2N data bits, X is an integer multiple of 2N, a plurality of read data words applied to the data bus simultaneously; and

applying a data bus inversion signal <u>for each read data word of the plurality</u> on <u>an associated</u> [[the]] data masking pin, the data bus inversion signal indicating whether the data contained in each <u>respective</u> read data word has been inverted.

6. (Currently amended) The method of claim 5 wherein <u>each</u> [[the]] data bus inversion signal corresponds to a sequence of bits, each bit indicating whether a corresponding read data word in the sequence is to be inverted or not be inverted, and the bit associated with a particular read data word is applied on the data masking pin coincident with the particular read data word being placed on the data bus.

7. (Currently amended) The method of claim 5 wherein each read data word includes a plurality of data bits, and wherein applying a data bus inversion signal for each read data word on the associated data masking pin comprises:

comparing the logic state of each data bit in a current read data word being placed on the data bus to the logic state of a corresponding data bit in a next read data word in the sequence that is to be placed on the data bus;

determining the number of data bits in the next read data word that are changing from a first logic state in the current read data word to the complementary logic state in the next read data word;

when the determined number of data bits changing from the first logic state to the complementary logic state is greater than N,

developing an inverted next read data word, each data signal in the inverted next read data word having a logic state that is the complementary logic state of the corresponding data signal in the next read data word;

activating the data bus inversion signal; and

placing the inverted next read data word on the data bus and the activated data bus inversion signal on the data masking pin; and

when the determined number of data bits changing from the first logic state to the complementary logic state is less than or equal to N,

deactivating the data bus inversion signal; and

placing the next read data word on the data bus and the deactivated data bus inversion signal on the data masking pin.

8-15. (Cancelled)

16. (Original) A memory device, comprising:an address bus;a control bus;a data bus;

an address decoder coupled to the address bus;

a control circuit coupled to the control bus;

a memory-cell array coupled to the address decoder, control circuit, and

read/write circuit;

a data masking terminal adapted to receive a data masking signal during write operations of the memory device; and

a read/write circuit coupled to the data bus, memory-cell array, and the data masking terminal, the read/write circuit operable during read operations to compare the number of bits changing from a first logic state in a current read data word on the data bus to the complementary logic state in a next read data word received from the memory-cell array, and operable in a first mode when the number of bits changing state is greater than a threshold value to apply an inverted next read data word on the data bus and apply an active a data bus inversion signal on the data masking terminal, and operable in a second mode when the number of bits changing state is less than or equal to the threshold value to apply the next read data word on the data bus and apply an inactive data bus inversion signal on the data masking terminal.

- 17. (Original) The memory device of claim 16 wherein the memory device comprises a DDR SDRAM.
- 18. (Original) The memory device of claim 16 further comprising a plurality of data masking terminals and the read/write circuit operable to compare groups of bits in the current and next read data words, and to develop a corresponding data bus inversion signal for each group and apply each data bus inversion signal on a respective data masking terminal.
- 19. (Original) The memory device of claim 16 wherein the read/write circuit comprises:

a storage circuit coupled to the memory-cell array to receive a true read data word including a plurality of bits, and the storage circuit operable to store each true read data word responsive to a clock signal;

an inversion circuit coupled to the storage circuit to receive the stored true read data word and operable responsive to an inversion control signal being active to invert the bits in the stored read data word to generate an inverted read data word and apply the inverted read data word on an output, and operable responsive to the inversion control signal being inactive to apply the true read data word on the output;

a data driver circuit coupled to the output of the inversion circuit and to the data bus, and operable to apply the read data word from the inversion circuit on the data bus responsive to a clocks signal; and

a comparison circuit coupled to the storage circuit to receive the true read data word and to the data bus to receive the current read data word, and operable to determine the number of bits changing from the first logic state to the complementary logic state and to activate the inversion control signal responsive to the number of bits being greater than the threshold value and deactivate the inversion control signal responsive to the number of bits being less than or equal to the threshold value.

20. (Original) A memory device, comprising:

an address bus;

a control bus;

a data bus:

an address decoder coupled to the address bus;

a control circuit coupled to the control bus;

a memory-cell array coupled to the address decoder, control circuit, and read/write circuit; and

a read/write circuit coupled to the data bus and the memory-cell array, the read/write circuit operable during read operations to generate a sequence of read data words including at least one data word including data bus inversion data, and operable to apply the sequence of read data words on the data bus.

- 21. (Original) The memory device of claim 20 wherein the read/write circuit is further operable during write operations to store a sequence of write data words received on the data bus and thereafter apply data bus inversion data contained in at least one of the received write data words invert or not invert data contained in the other write data words and transfer the data to the memory-cell array.
- 22. (Original) The memory device of claim 20 wherein the memory device comprises a DDR SDRAM.
- 23. (Original) The memory device of claim 20 wherein the sequence of read data words comprises 9 read data words, one of the read data words including the data bus inversion data.
- 24. (Original) The memory device of claim 23 wherein each read data word includes 32 bits, and each of the 32 bits in the data word including the data bus inversion data applies to a corresponding byte in one of the 8 other read data words.
 - 25. (Original) A computer system, comprising:
 - a data input device;
 - a data output device;
 - a processor coupled to the data input and output devices; and
- a memory device coupled to the processor, the memory device comprising,

an address bus;

a control bus;

a data bus;

an address decoder coupled to the address bus;

a control circuit coupled to the control bus;

a memory-cell array coupled to the address decoder, control circuit, and read/write circuit;

a data masking terminal adapted to receive a data masking signal during write operations of the memory device; and

a read/write circuit coupled to the data bus, memory-cell array, and the data masking terminal, the read/write circuit operable during read operations to compare the number of bits changing from a first logic state in a current read data word on the data bus to the complementary logic state in a next read data word received from the memory-cell array, and operable in a first mode when the number of bits changing state is greater than a threshold value to apply an inverted next read data word on the data bus and apply an active a data bus inversion signal on the data masking terminal, and operable in a second mode when the number of bits changing state is less than or equal to the threshold value to apply the next read data word on the data bus and apply an inactive data bus inversion signal on the data masking terminal.

- 26. (Original) The computer system of claim 25 wherein the memory device comprises a DDR SDRAM.
- 27. (Original) The computer system of claim 25 further comprising a plurality of data masking terminals and the read/write circuit operable to compare groups of bits in the current and next read data words, and to develop a corresponding data bus inversion signal for each group and apply each data bus inversion signal on a respective data masking terminal.
- 28. (Original) The computer system of claim 25 wherein the read/write circuit comprises:

a storage circuit coupled to the memory-cell array to receive a true read data word including a plurality of bits, and the storage circuit operable to store each true read data word responsive to a clock signal;

an inversion circuit coupled to the storage circuit to receive the stored true read data word and operable responsive to an inversion control signal being active to invert the

comprising,

bits in the stored read data word to generate an inverted read data word and apply the inverted read data word on an output, and operable responsive to the inversion control signal being inactive to apply the true read data word on the output;

a data driver circuit coupled to the output of the inversion circuit and to the data bus, and operable to apply the read data word from the inversion circuit on the data bus responsive to a clocks signal; and

a comparison circuit coupled to the storage circuit to receive the true read data word and to the data bus to receive the current read data word, and operable to determine the number of bits changing from the first logic state to the complementary logic state and to activate the inversion control signal responsive to the number of bits being greater than the threshold value and deactivate the inversion control signal responsive to the number of bits being less than or equal to the threshold value.

- 29. (Original) A computer system, comprising:
 - a data input device;
 - a data output device;
 - a processor coupled to the data input and output devices; and
 - a memory device coupled to the processor, the memory device

an address bus;

a control bus;

a data bus;

an address decoder coupled to the address bus;

a control circuit coupled to the control bus;

a memory-cell array coupled to the address decoder, control circuit, and read/write circuit; and

a read/write circuit coupled to the data bus and the memory-cell array, the read/write circuit operable during read operations to generate a sequence of read data

words including at least one data word including data bus inversion data, and operable to apply the sequence of read data words on the data bus.

- 30. (Original) The computer system of claim 29 wherein the read/write circuit is further operable during write operations to store a sequence of write data words received on the data bus and thereafter apply data bus inversion data contained in at least one of the received write data words invert or not invert data contained in the other write data words and transfer the data to the memory-cell array.
- 31. (Original) The computer system of claim 29 wherein the memory device comprises a DDR SDRAM.
- 32. (Original) The computer system of claim 29 wherein the sequence of read data words comprises 9 read data words, one of the read data words including the data bus inversion data.
- 33. (Original) The computer system of claim 32 wherein each read data word includes 32 bits, and each of the 32 bits in the data word including the data bus inversion data applies to a corresponding byte in one of the 8 other read data words.